



## P-Channel Enhancement Mode Field Effect Transistor

### ● Features

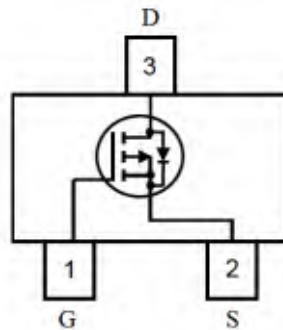
$V_{DS} (V) = -20V, I_D = -3.1A$

$R_{DS(ON)} < 90m\Omega @ V_{GS} = -4.5V$

$R_{DS(ON)} < 120m\Omega @ V_{GS} = -2.5V$

SOT23 Package

### ● Pin Configurations



### ● General Description

These P-Channel enhancement mode field effect transistors are produced using high cell density, DMOS technology.

### ● Absolute Maximum Ratings @ $T_A=25^\circ C$ unless otherwise noted

Parameter		Symbol	Ratings	Unit
Drain-Source Voltage		$V_{DSS}$	-20	V
Gate-Source Voltage		$V_{GSS}$	$\pm 8$	V
Drain Current (Continuous)	$T_A=25^\circ C$	$I_D$	-2.8	A
	$T_A=70^\circ C$		-2.1	
Drain Current (Pulse)		$I_{DM}$	-10	A
Power Dissipation	$T_A=25^\circ C$	$P_D$	1	W
Operating Temperature/ Storage Temperature		$T_J/T_{STG}$	-55~150	°C

**● Electrical Characteristics @TA=25°C unless otherwise noted**

Parameter	Symbol	Test Conditions	Min	Typ	Max	Unit
<b>ON/OFF CHARACTERISTICS</b>						
Drain-Source Breakdown Voltage	$V_{(BR)DSS}$	$V_{GS} = 0V, I_D = -250\mu A$	-20	--	--	V
Zero Gate Voltage Drain Current	$I_{DSS}$	$V_{DS} = -20 V, V_{GS} = 0V$	--	--	-1	$\mu A$
Gate Threshold Voltage	$V_{GS(th)}$	$V_{GS} = V_{DS}, I_{DS} = -250\mu A$	-0.5	-0.65	-1	V
Gate Leakage Current	$I_{GSS}$	$V_{GS} = \pm 8V, V_{DS} = 0V$	--	--	$\pm 100$	nA
Drain-Source On-state Resistance	$R_{DS(on)}$	$V_{GS} = -4.5V, I_D = -2.8A$	--	70	90	$m\Omega$
		$V_{GS} = -2.5V, I_D = -2A$	--	85	120	$m\Omega$
		$V_{GS} = -1.8V, I_D = -2A$	--	110	150	$m\Omega$
Forward Transconductance	$g_{FS}$	$V_{DS} = -5V, I_D = -3A$	--	7	--	S
Diode Forward Voltage	$V_{SD}$	$I_{SD} = -1.6A, V_{GS} = 0V$	--	-0.75	-1.0	V
<b>Switching CHARACTERISTICS</b>						
Total Gate Charge	$Q_g$	$V_{DS} = -6V, I_D = -2.8A$ $V_{GS} = -4.5V$	--	6.6	8.6	nC
Gate-Source Charge	$Q_{gs}$		--	0.3	0.4	nC
Gate-Drain Charge	$Q_{gd}$		--	1.3	1.7	nC
Turn-on Delay Time	$t_{d(on)}$	$V_{DD} = -6V, RL = 6\Omega$ $I_D = -1A, V_{GEN} = -4.5V$ $R_G = 6\Omega$	--	9.7	19.4	ns
Turn-on Rise Time	$t_r$		--	3.6	7.1	ns
Turn-off Delay Time	$t_{d(off)}$		--	33.3	66.6	ns
Turn-off Fall Time	$t_f$		--	4.5	9	ns
<b>Dynamic CHARACTERISTICS</b>						
Input Capacitance	$C_{iss}$	$V_{GS} = 0V, V_{DS} = -6V, f = 1.0MHz$	--	589	--	pF
Output Capacitance	$C_{oss}$		--	91.2	--	pF
Reverse Transfer Capacitance	$C_{rss}$		--	67.2	--	pF

Notes:

1. Pulse width limited by maximum junction temperature.
2. Pulse test: PW  $\leq 300\mu s$ , duty cycle  $\leq 2\%$ .
3. For design AID only, not subject to production testing.
4. Switching time is essentially independent of operating temperature.



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### Typical Performance Characteristics

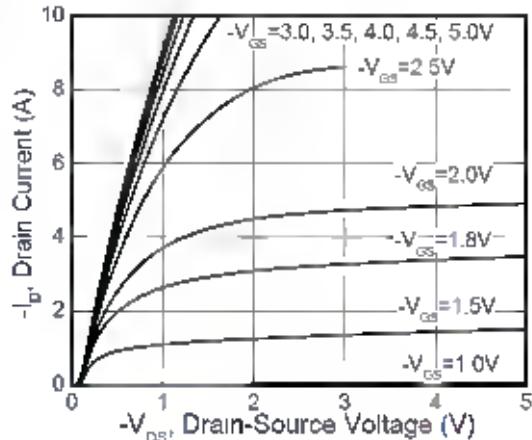


Figure 1. Output Characteristics

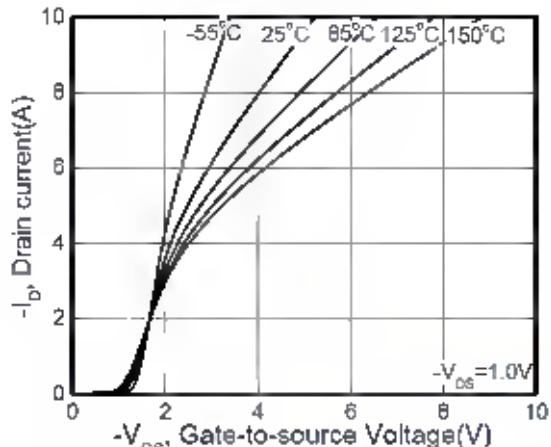


Figure 2. Transfer Characteristics

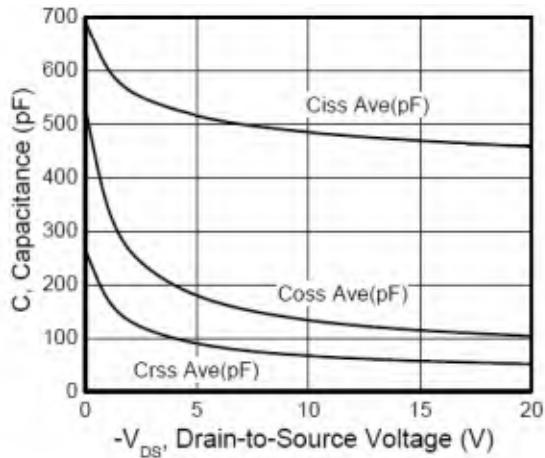


Figure 3. Capacitance

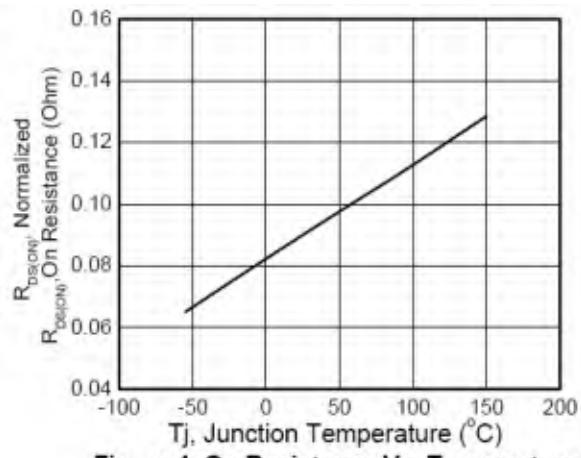


Figure 4. On Resistance Vs. Temperature

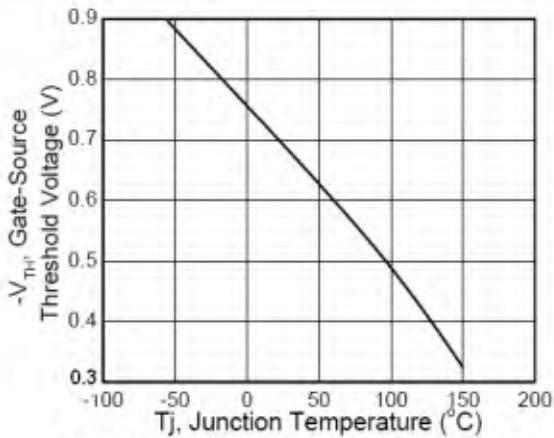


Figure 5. Gate Threshold Vs. Temperature

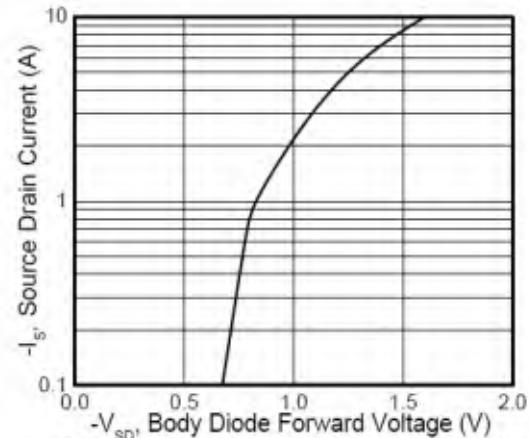
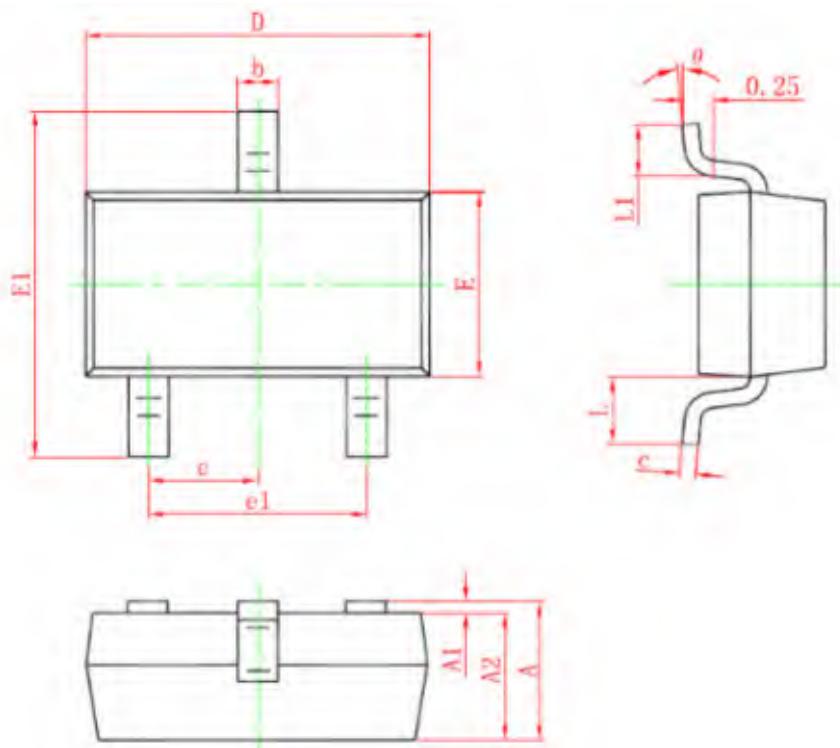


Figure 6. Body Diode Forward Voltage  
Vs. Source Current



- Package Information



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min.	Max.	Min.	Max.
A	0.900	1.150	0.035	0.045
A1	0.000	0.100	0.000	0.004
A2	0.900	1.050	0.035	0.041
b	0.300	0.500	0.012	0.020
c	0.080	0.150	0.003	0.006
D	2.800	3.000	0.110	0.118
E	1.200	1.400	0.047	0.055
E1	2.250	2.550	0.089	0.100
e	0.950 TYP.		0.037 TYP.	
e1	1.800	2.000	0.071	0.079
L	0.550 REF.		0.022 REF.	
L1	0.300	0.500	0.012	0.020
θ	0°	8°	0°	8°